Notice of References Cited Application/Control No. 10/772,451 Examiner DeMaris R. Wilson Applicant(s)/Patent Under Reexamination HADA ET AL. Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-7,134,298	11-2006	Fukuyama et al.	65/29.19
*	В	US-5,346,522	09-1994	Komiyama et al.	65/64
*	С	US-2006/0090512	05-2006	Fujimoto et al.	065/029.19
*	D	US-2006/0059949	03-2006	Fujimoto, Tadayuki	065/032.5
*	Е	US-5,085,570	02-1992	Leinweber, Johann	425/195
*	F	US-2004/0212110	10-2004	Fujimoto et al.	264/001.32
*	G	US-7,143,617	12-2006	Futamura et al.	72/20.1
*	Н	US-7,108,812	09-2006	Hosoe, Shigeru	264/2.5
*	1	US-5,264,016	11-1993	Komiyama, Yoshizo	65/29.1
*	J	US-5,944,646	08-1999	Weder et al.	493/84
*	К	US-5,282,878	02-1994	Komiyama et al.	65/162
*	T	US-6,928,838	08-2005	Murakoshi et al.	65/102
*	М	US-2005/0279137	12-2005	Fukuyama et al.	065/162

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
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	Р					A TOTAL A
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	R					
	S					
	Т					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	V	
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	×	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

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